Abstract Submitted for the MAR14 Meeting of The American Physical Society

Modeling vitreous silica bilayers AVISHEK KUMAR, Department of Physics, Arizona State University, MARK WILSON, Department of Chemistry, Physical and Theoretical Chemistry Laboratory, University of Oxford, DAVID SHERRINGTON, Department of Theoretical Physics, University of Oxford, MICHAEL THORPE, Department of Physics, Arizona State University — The recent synthesis and imaging of bilayers of vitreous silica has led to a wealth of new information [1-2]. We have modeled the experimentally-observed bilayer using a computer assembly procedure [3] to form a network of corner-sharing tetrahedra, which is then mirror-reflected to form a bilayer. We show that the vitreous silica bilayer has additional macroscopic degrees of freedom iff there is a symmetry plane through the center of the bilayer going through the central layer of oxygen ions that join the upper and lower monolayers. We have computer-refined the experimental coordinates to determine the density, and other structural characteristics such as the Si-Si pair distribution function, Si-O-Si bond angle distribution and the Aboav-Weaire law. [1] P. Y. Huang, S. Kurasch, A. Srivastava, V. Skakalova, J. Kotakoski, A. V. Krasheninnikov, R. Hovden, Q. Mao, J. C. Meyer, J. Smet, D. A. Muller, and U. Kaiser, Nano. Lett. 12, 1081 (2012). [2] M. Heyde, S. Shaikhutdinov, and J. J. Freund, Chem. Phys. Lett. 550, 1 (2012). [3] M. Wilson, A. Kumar, D. Sherrington, M.F. Thorpe, Phys. Rev. B (87) 214108 (2013)

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